

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HAAS ET AL.	
		Examiner Huan H. Tran	Art Unit 2861	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0124451	07-2003	Camillus et al.	430/138
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 03/040825	05-2003	WO	Camillus et al	G03F007/00
	O	JP 2000-71517	03-2000	Japan	Saigo et al	B41J002/44
	P	JP 10-198043	07-1998	Japan	Brother	B41J002/44
	Q	JP 2001-212998	08-2001	Japan	Tozaki	B41J002/435
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.